

Notice of References Cited

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Application/Control No. 10/022,278

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Applicant(s)/Patent Under Reexamination FUJII ET AL.

Examiner
Tai Van Nguyen

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,900,790	05-1999	Unami et al.	333/187
	В	US-5,585,687	12-1996	Wakabayashi et al.	310/366
	С	US-			<u> </u>
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FOREIGN PATENT DOCUMENTS

*	:	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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